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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 07977-150003	Application No. 09/696,863	
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Yamazaki, et al.		
		Filing Date October 25, 2000	Group Art Unit 2881	

	U.S. Patent Documents						
Examiner Iniţial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
ANS	AA	6,160,262	12/12/2000	Aoki et al.			
	AB						
	AC						
	AD						
	AE						
	AF						

	Foreign Patent Documents or Published Foreign Patent Applications							
Examiner	Desig.	Document	Publication	Country or			Trans	slation
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
415	AG	08-077961	03/22/1996	Japan			X	
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416	AO	M. Naito et al. "High Current Ion Implantation System for Research Use, PR-200A-RD", The Nissin Electric Review, Vol. 35, No. 2, 1990, pp. 25-31
45	AP	N. Nagai et al. "New Generation Parallel Beam Implanter EXCEED 2000", The Nissin Electric Review, Vol. 39, No. 3, 1994, pp. 9-18
	AQ	
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<b>EXAMINER:</b> Initials citation con	sidered. Draw line through citation if no	ot in conformance and not considered	. Include copy of this form with

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	Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 07977/150003/US3336/3421D1D1	Application No. 09/696,863
Information Disclosure Statement  (by Applicant		Applicant Yamazaki, et al.		
	(Use several sh	neets (chècessary) 2002 N	Filing Date October 25, 2000	Group Art Unit 2887
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Examiner Initial	Desig.	MADE SENT Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
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	AB						
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•	Foreig	n Patent Doo	cuments or P	ublished Foreign	Patent A	Application	าร	
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	AP							J

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Examiner Initial	Desig. ID	Document		
	AQ			
	AR			
	AS			

Examiner Signature	Date Considered				
Examiner Signature Willista (Tolla	May 16, 2003				
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